

NTE2995 MOSFET N-Channel, Enhancement Mode High Speed Switch

Features:

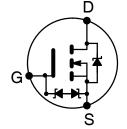
- $R_{DS(on)} = 0.65\Omega$ Typical
- Extrèmely High dv/dt Capability
- Gate Charge Minimized

Absolute Maximum Ratings:

Gate-to-Source Zener Diode Protected

Applications:

- High Current, High Speed Switching
- Ideal for Off-Line Power Supplies, Adaptor and PFC
- Lighting



Drain-Source Voltage (V _{GS} = 0), V _{DS}
Drain–Gate Voltage ($R_{GS} = 20k\Omega$), V_{DGR}
Gate-Source Voltage, V _{GS} ±30V
Drain Current, I _D
Continuous
$T_C = +25^{\circ}C$
$T_C = +100^{\circ}C$
Pulsed (Note 1)
Total Power Dissiption ($T_C = +25^{\circ}C$), P_{TOT}
Derate Above +25°C
Gate-Source ESD Voltage (HBM C = 100pF, R = 1.5k Ω), V _{esd(G-S)} 4000V
Peak Diode Recovery Voltage Slope (Note 2), dv/dt
Avalanche Current, Repetitive or Non-Repetitive (Pulse Width Limited by T _J max), I _{AR} 9A
Single Pulse Avalanche Energy (Starting $T_J = +25^{\circ}C$, $I_D = I_{AR}$, $V_{DD} = 50V$), E_{AS} 300mJ
Repetitive Avalanche Energy (Pulse Width Limited by T _J max), E _{AR}
Minimum Gate-Source Breakdown Voltage ($I_{GS} = \pm 1 \text{mA}$, Open Drain, Note 3), $V_{(BR)GSO} \dots 30V$
Operating Junction Temperature Range, T _J
Storage Temperature Range, T _{stq}
Thermal Resistance, Junction-to-Case, R _{thJC}
Thermal Resistance, Junction–to–Ambient, R _{thJA}
Lead Temperature (During Soldering), T _L +300°C
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- Note 1. Pulse width limited by safe operating area.
- Note 2. $I_{SD} \le 10A$, $di/dt \le 200A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J \le T_J max$.
- Note 3. The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect their Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

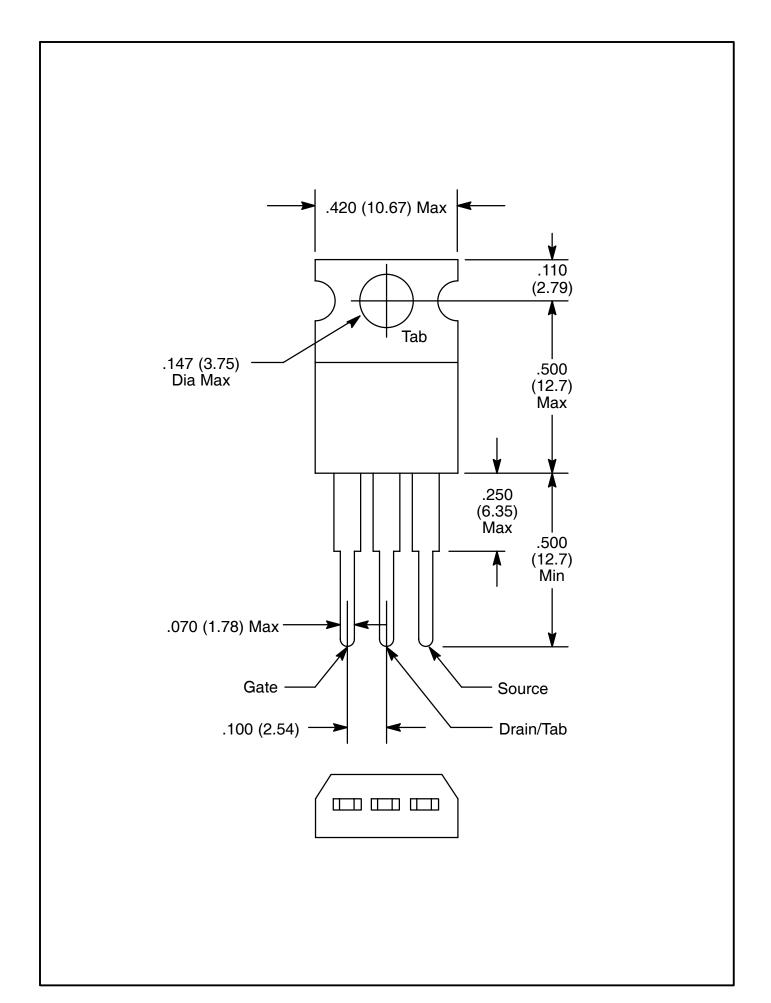
Electrical Characteristics: $(T_C = +25^{\circ}C \text{ unless otherwise specified})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
ON/OFF						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0$	600	_	_	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Max Rating	_	_	1	μΑ
		V _{DS} = Max Rating, T _J = +125°C	_	_	50	μΑ
Gate Body Leakage Current	I _{GSS}	$V_{GS} = \pm 15V, V_{DS} = 0$	_	_	±10	μΑ
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	3.0	3.75	4.5	V
Static Drain-Source ON Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 4.5A	_	0.65	0.75	Ω
Dynamic		•	I			I
Forward Transconductance	9 _{fs}	V _{DS} = 15V, I _D = 4.5A, Note 4	_	7.8	_	S
Input Capacitance	C _{iss}	$V_{DS} = 25V$, $f = 1MHz$, $V_{GS} = 0$	_	1370	-	рF
Output Capacitance	Coss		_	156	-	pF
Reverse Transfer Capacitance	C _{rss}		_	37	-	рF
Equivalent Output Capacitance	C _{oss eq.}	$V_{GS} = 0$, $V_{DS} = 0V$ to 480V, Note 5	_	90	-	pF
Total Gate Charge	Qg	$V_{DD} = 480V$, $I_{D} = 8A$, $V_{GS} = 10V$	_	50	70	nC
Gate-Source Charge	Q _{gs}		_	10	-	nC
Gate-Drain Charge	Q _{gd}		_	25	-	nC
Switching ON/OFF						
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 300V$, $I_{D} = 4A$, $R_{G} = 4.7\Omega$, $V_{GS} = 10V$	_	20	_	ns
Rise Time	t _r		_	20	-	ns
Turn-Off Delay Time	t _{d(off)}		_	55	_	ns
Fall Time	t _f		_	30	_	ns
Off-Voltage Rise Time	t _{r(Voff)}	$V_{DD} = 480V, I_{D} = 8A, R_{G} = 4.7\Omega, V_{GS} = 10V$	_	18	_	ns
Fall Time	t _f		_	18	_	ns
Crossover Time	t _c		_	36	_	ns
Source-Drain Diode						
Source-Drain Current	I _{SD}		_	_	10	Α
Source-Drain Current, Pulsed	I _{SDM}	Note 1	_	_	36	Α
Forward ON Voltage	V _{SD}	I _{SD} = 10A, V _{GS} = 0, Note 4	-	_	1.6	V
Reverse Recovery Time	t _{rr}	I _{SD} = 8A, di/dt = 100A/μs, V _{DD} = 40V, T _J = +150°C	_	570	_	ns
Reverse Recovery Charge	Q _{rr}		_	4.3	_	μС
Reverse Recovery Current	I _{RRM}		_	15	_	Α

Note 1. Pulse width limited by safe operating area.

Note 4. Pulsed: pulse duration = $300\mu s$, duty cycle 1.5%.

Note 5. $C_{\rm oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as $C_{\rm oss}$ when $V_{\rm DS}$ increases from 0 to 80%.



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